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Details

Product Status	Active
Core Processor	12V1
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, IrDA, LINbus, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	40
Program Memory Size	48KB (48K x 8)
Program Memory Type	FLASH
EEPROM Size	1.5K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	3.13V ~ 5.5V
Data Converters	A/D 12x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/s9s12ga48f0mlf

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1.8.9.3 Pinout 100-Pin LQFP



Figure 1-26. 100-Pin LQFP Pinout for S12GA192 and S12GA240

	Function <lowestpriorityhighest></lowestpriorityhighest>					Internal Pull Resistor	
Wire Bond Die Pad	Pin	2nd Func.	3rd Func.	4th Func.	Supply	CTRL	Reset State
56	PAD8	KWAD8	AN8	_	V _{DDA}	PER0AD/PPS0AD	Disabled
57	PAD1	KWAD1	AN1	_	V _{DDA}	PER1AD/PPS1AD	Disabled
58	PAD9	KWAD9	AN9	_	V _{DDA}	PER0AD/PPS0AD	Disabled
59	PAD2	KWAD2	AN2	—	V _{DDA}	PER1AD/PPS1AD	Disabled
60	PAD10	KWAD10	AN10	AMP1	V _{DDA}	PER0AD/PPS0AD	Disabled
61	PAD3	KWAD3	AN3	—	V _{DDA}	PER1AD/PPS1AD	Disabled
62	PAD11	KWAD11	AN11	AMP0	V _{DDA}	PER0AD/PPS0AD	Disabled
63	PAD4	KWAD4	AN4	—	V _{DDA}	PER1AD/PPS1AD	Disabled
64	PAD12	KWAD12	AN12	—	V _{DDA}	PER0AD/PPS0AD	Disabled
65	PAD5	KWAD5	AN5	—	V _{DDA}	PER1AD/PPS1AD	Disabled
66	PAD13	KWAD13	AN13	AMPM0	V _{DDA}	PER0AD/PPS0AD	Disabled
67	PAD6	KWAD6	AN6	—	V _{DDA}	PER1AD/PPS1AD	Disabled
68	PAD14	KWAD14	AN14	AMPP0	V _{DDA}	PER0AD/PPS0AD	Disabled
69	PAD7	KWAD7	AN7	—	V _{DDA}	PER1AD/PPS1AD	Disabled
70	PAD15	KWAD15	AN15	DACU0	V _{DDA}	PER0AD/PPS0AD	Disabled
71	PC4	—	—	—	V _{DDA}	PUCR/PUPCE	Disabled
72	PC5	AMPM1	—	—	V _{DDA}	PUCR/PUPCE	Disabled
73	PC6	AMPP1	—	—	V _{DDA}	PUCR/PUPCE	Disabled
74	PC7	DACU1	—	—	V _{DDA}	PUCR/PUPCE	Disabled
75	VRH	—	—	—	_		
76	VDDA	—	—	—	—		
77	VSSA	—	—	—	—		
78	PD0	—	—	—	V _{DDX}	PUCR/PUPDE Disable	
79	PD1	—	—	—	V _{DDX}	PUCR/PUPDE Disab	
80	PD2	_	_	_	V _{DDX}	DDX PUCR/PUPDE Di	
81	PD3	_		_	V _{DDX}	PUCR/PUPDE Disabl	
82	PS0	RXD0	_	_	V _{DDX}	PERS/PPSS	Up
83	PS1	TXD0			V _{DDX}	PERS/PPSS	Up
84	PS2	RXD1			V _{DDX}	PERS/PPSS	Up

Table 1-32. KGD Option for S12GA192 and S12GA240
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2.3.5 Pins PD7-0

Table 2-9. Port D Pins PD7-0

PD7-PD0 • These pins feature general-purpose I/O functionality only.

2.3.6 Pins PE1-0

Table 2-10. Port E Pins PE1-0

PE1	 If the CPMU OSC function is active this pin is used as XTAL signal and the pulldown device is disabled. 20 TSSOP: The SCI0 TXD signal is mapped to this pin when used with the SCI function. If the SCI0 TXD signal is enabled and routed here the I/O state will depend on the SCI0 configuration. 20 TSSOP: The TIM channel 3 signal is mapped to this pin when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. 20 TSSOP: The PWM channel 1 signal is mapped to this pin when used with the PWM function. The enabled PWM channel forces the I/O state to be an output. 20 TSSOP: The ADC ETRIG1 signal is mapped to this pin when used with the ADC function. The enabled external trigger function has no effect on the I/O state. Refer to Section 2.6.4, "ADC External Triggers ETRIG3-0". Signal priority: 20 TSSOP: XTAL > TXD0 > IOC3 > PWM1 > GPO Others: XTAL > GPO
PE0	 If the CPMU OSC function is active this pin is used as EXTAL signal and the pulldown device is disabled. 20 TSSOP: The SCI0 RXD signal is mapped to this pin when used with the SCI function. If the SCI0 RXD signal is enabled and routed here the I/O state will be forced to input. 20 TSSOP: The TIM channel 2 signal is mapped to this pin when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. 20 TSSOP: The PWM channel 0 signal is mapped to this pin when used with the PWM function. The enabled PWM channel forces the I/O state to be an output. 20 TSSOP: The ADC ETRIGO signal is mapped to this pin when used with the ADC function. The enabled external trigger function has no effect on the I/O state. Refer to Section 2.6.4, "ADC External Triggers ETRIG3-0". Signal priority: 20 TSSOP: EXTAL > RXD0 > IOC2 > PWM0 > GPO Others: EXTAL > GPO

2.3.7 Pins PT7-0

Table 2-11. Port T Pins PT7-0

PT7-PT6	 64/100 LQFP: The TIM channels 7 and 6 signal are mapped to these pins when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. Signal priority: 64/100 LQFP: IOC7-6 > GPO
PT5	 48/64/100 LQFP: The TIM channel 5 signal is mapped to this pin when used with the timer function. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. If the ACMP timer link is enabled this pin is disconnected from the timer input so that it can still be used as general-purpose I/O or as timer output. The use case for the ACMP timer link requires the timer input capture function to be enabled. Signal priority: 48/64/100 LQFP: IOC5 > GPO

PAD9	 48/64 LQFP: The ACMPO signal of the analog comparator is mapped to this pin when used with the ACMP function. If the ACMP output is enabled (ACMPC[ACOPE]=1) the I/O state will be forced to output. 48/64/100 LQFP: The ADC analog input channel signal AN9 and the related digital trigger input are mapped to this pin. The ADC function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. 48/64/100 LQFP: Pin interrupts can be generated if enabled in digital input or output mode. Signal priority: 48 LQFP: ACMPO > GPO 64/100 LQFP: GPO
PAD8	 48/64/100 LQFP: The ADC analog input channel signal AN8 and the related digital trigger input are mapped to this pin. The ADC function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. 48/64/100 LQFP: Pin interrupts can be generated if enabled in digital input or output mode. Signal priority: 48/64/100 LQFP: GPO
4	

Table 2-16. Port AD Pins AD15-8

¹ AMP output takes precedence over DACU output on shared pin.

Table 2-17. Port AD Pins AD7-0

PAD7	 32 LQFP: The inverting input signal ACMPM of the analog comparator is mapped to this pin when used with the ACMP function. The ACMP function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. Except 20 TSSOP: The ADC analog input channel signal AN7 and the related digital trigger input are mapped to this pin. The ADC function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. Except 20 TSSOP: Pin interrupts can be generated if enabled in digital input or output mode. Signal priority: Except 20 TSSOP: GPO
PAD6	 32 LQFP: The non-inverting input signal ACMPP of the analog comparator is mapped to this pin when used with the ACMP function. The ACMP function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. Except 20 TSSOP: The ADC analog input channel signal AN6 and the related digital trigger input are mapped to this pin. The ADC function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. Except 20 TSSOP: Pin interrupts can be generated if enabled in digital input or output mode. Signal priority: Except 20 TSSOP: GPO

PAD5	 32 LQFP: The ACMPO signal of the analog comparator is mapped to this pin when used with the ACMP function. If the ACMP output is enabled (ACMPC[ACOPE]=1) the I/O state will be forced to output. 20 TSSOP: The inverting input signal ACMPM of the analog comparator is mapped to this pin when used with the ACMP function. The ACMP function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. The ADC analog input channel signal AN5 and the related digital trigger input are mapped to this pin. The ADC function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. 20 TSSOP: The SCI0 TXD signal is mapped to this pin. If the SCI0 TXD signal is enabled the I/O state will depend on the SCI0 configuration. 20 TSSOP: The TIM channel 3 signal is mapped to this pin. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. 20 TSSOP: The PWM channel 3 signal is mapped to this pin. If the PWM channel is enabled and routed here the I/O state is forced to output. 20 TSSOP: The ADC ETRIG3 signal is mapped to this pin if PWM channel 3 is routed here. The enabled external trigger function has no effect on the I/O state. Refer to Section 2.6.4, "ADC External Triggers ETRIG3-0". Pin interrupts can be generated if enabled in digital input or output mode. Signal priority: 32 LQFP: ACMPO > GPO 20 TSSOP: TXD0 > IOC3 > PWM3 > GPO Others: GPO
PAD4	 20 TSSOP: The non-inverting input signal ACMPP of the analog comparator is mapped to this pin when used with the ACMP function. The ACMP function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. The ADC analog input channel signal AN4 and the related digital trigger input are mapped to this pin. The ADC function has no effect on the output state. Refer to NOTE/2-172 for input buffer control. 20 TSSOP: The SCI0 RXD signal is mapped to this pin. If the SCI0 RXD signal is enabled and routed here the I/O state will be forced to input. 20 TSSOP: The TIM channel 2 signal is mapped to this pin. The TIM forces the I/O state to be an output for a timer port associated with an enabled output compare. 20 TSSOP: The PWM channel 2 signal is mapped to this pin. If the PWM channel is enabled and routed here the I/O state is forced to output. 20 TSSOP: The ADC ETRIG2 signal is mapped to this pin if PWM channel 2 is routed here. The enabled external trigger function has no effect on the I/O state. Refer to Section 2.6.4, "ADC External Triggers ETRIG3-0". Pin interrupts can be generated if enabled in digital input or output mode. Signal priority: 20 TSSOP: RXD0 > IOC2 > PWM2 > GPO Others: GPO

Field	Description
7-0 PPSS	 Port S pull device select—Configure pull device polarity on input pin This bit selects a pullup or a pulldown device if enabled on the associated port input pin. 1 Pulldown device selected 0 Pullup device selected

2.4.3.25 Port S Wired-Or Mode Register (WOMS)

Address 0x024E

Access: User read/write1

	7	6	5	4	3	2	1	0
R W	WOMS7	WOMS6	WOMS5	WOMS4	WOMS3	WOMS2	WOMS1	WOMS0
Reset	0	0	0	0	0	0	0	0

Figure 2-26. Port S Wired-Or Mode Register (WOMS)

¹ Read: Anytime

Write: Anytime

Table 2-45. WOMS Register Field Descriptions

Field	Description
7-0 WOMS	 Port S wired-or mode—Enable open-drain functionality on output pin This bit configures an output pin as wired-or (open-drain) or push-pull. In wired-or mode a logic "0" is driven active-low while a logic "1" remains undriven. This allows a multipoint connection of several serial modules. The bit has no influence on pins used as input. 1 Output buffer operates as open-drain output. 0 Output buffer operates as push-pull output.

2.4.3.26 Pin Routing Register 0 (PRR0)

NOTE

Routing takes only effect if PKGCR is set to select the 20 TSSOP package.



NOTE

If an attempt is made to activate BDM before being enabled, the CPU resumes normal instruction execution after a brief delay. If BDM is not enabled, any hardware BACKGROUND commands issued are ignored by the BDM and the CPU is not delayed.

In active BDM, the BDM registers and standard BDM firmware lookup table are mapped to addresses 0x3_FF00 to 0x3_FFFF. BDM registers are mapped to addresses 0x3_FF00 to 0x3_FF0B. The BDM uses these registers which are readable anytime by the BDM. However, these registers are not readable by user programs.

When BDM is activated while CPU executes code overlapping with BDM firmware space the saved program counter (PC) will be auto incremented by one from the BDM firmware, no matter what caused the entry into BDM active mode (BGND instruction, BACKGROUND command or breakpoints). In such a case the PC must be set to the next valid address via a WRITE_PC command before executing the GO command.

7.4.3 BDM Hardware Commands

Hardware commands are used to read and write target system memory locations and to enter active background debug mode. Target system memory includes all memory that is accessible by the CPU such as on-chip RAM, Flash, I/O and control registers.

Hardware commands are executed with minimal or no CPU intervention and do not require the system to be in active BDM for execution, although, they can still be executed in this mode. When executing a hardware command, the BDM sub-block waits for a free bus cycle so that the background access does not disturb the running application program. If a free cycle is not found within 128 clock cycles, the CPU is momentarily frozen so that the BDM can steal a cycle. When the BDM finds a free cycle, the operation does not intrude on normal CPU operation provided that it can be completed in a single cycle. However, if an operation requires multiple cycles the CPU is frozen until the operation is complete, even though the BDM found a free cycle.

The BDM hardware commands are listed in Table 7-5.

The READ_BD and WRITE_BD commands allow access to the BDM register locations. These locations are not normally in the system memory map but share addresses with the application in memory. To distinguish between physical memory locations that share the same address, BDM memory resources are enabled just for the READ_BD and WRITE_BD access cycle. This allows the BDM to access BDM locations unobtrusively, even if the addresses conflict with the application memory map.

Command	Opcode (hex)	Data	Description
BACKGROUND	90	None	Enter background mode if BDM is enabled. If enabled, an ACK will be issued when the part enters active background mode.
ACK_ENABLE	D5	None	Enable Handshake. Issues an ACK pulse after the command is executed.
ACK_DISABLE	D6	None	Disable Handshake. This command does not issue an ACK pulse.

Table 7-5. Hardware Commands

16-bit misaligned reads and writes are generally not allowed. If attempted by BDM hardware command, the BDM ignores the least significant bit of the address and assumes an even address from the remaining bits.

For hardware data read commands, the external host must wait at least 150 bus clock cycles after sending the address before attempting to obtain the read data. This is to be certain that valid data is available in the BDM shift register, ready to be shifted out. For hardware write commands, the external host must wait 150 bus clock cycles after sending the data to be written before attempting to send a new command. This is to avoid disturbing the BDM shift register before the write has been completed. The 150 bus clock cycle delay in both cases includes the maximum 128 cycle delay that can be incurred as the BDM waits for a free cycle before stealing a cycle.

For BDM firmware read commands, the external host should wait at least 48 bus clock cycles after sending the command opcode and before attempting to obtain the read data. The 48 cycle wait allows enough time for the requested data to be made available in the BDM shift register, ready to be shifted out.

For BDM firmware write commands, the external host must wait 36 bus clock cycles after sending the data to be written before attempting to send a new command. This is to avoid disturbing the BDM shift register before the write has been completed.

The external host should wait for at least for 76 bus clock cycles after a TRACE1 or GO command before starting any new serial command. This is to allow the CPU to exit gracefully from the standard BDM firmware lookup table and resume execution of the user code. Disturbing the BDM shift register prematurely may adversely affect the exit from the standard BDM firmware lookup table.

NOTE

If the bus rate of the target processor is unknown or could be changing, it is recommended that the ACK (acknowledge function) is used to indicate when an operation is complete. When using ACK, the delay times are automated.

Figure 7-6 represents the BDM command structure. The command blocks illustrate a series of eight bit times starting with a falling edge. The bar across the top of the blocks indicates that the BKGD line idles in the high state. The time for an 8-bit command is 8×16 target clock cycles.¹

^{1.} Target clock cycles are cycles measured using the target MCU's serial clock rate. See Section 7.4.6, "BDM Serial Interface" and Section 7.3.2.1, "BDM Status Register (BDMSTS)" for information on how serial clock rate is selected.

S12S Debug Module (S12SDBGV2)

event B cause a trigger. Similarly 2 consecutive occurrences of event B without an intermediate event A cause a trigger. This is possible by using CompA and CompC to match on the same address as shown.





This scenario is currently not possible using 2 comparators only. S12SDBGV2 makes it possible with 2 comparators, State 3 allowing a M0 to return to state 2, whilst a M2 leads to final state as shown.





The advantage of using only 2 channels is that now range comparisons can be included (channel0)

This however violates the S12SDBGV1 specification, which states that a match leading to final state always has priority in case of a simultaneous match, whilst priority is also given to the lowest channel number. For S12SDBG the corresponding CPU priority decoder is removed to support this, such that on simultaneous taghits, taghits pointing to final state have highest priority. If no taghit points to final state then the lowest channel number has priority. Thus with the above encoding from State3, the CPU and DBG would break on a simultaneous M0/M2.

SC	CD	СС	СВ	CA	Analog Input Channel
0	0	0	0	0	ANO
	0	0	0	1	AN1
	0	0	1	0	AN2
	0	0	1	1	AN3
	0	1	0	0	AN4
	0	1	0	1	AN5
	0	1	1	0	AN6
	0	1	1	1	AN7
	1	0	0	0	AN7
	1	0	0	1	AN7
	1	0	1	0	AN7
	1	0	1	1	AN7
	1	1	0	0	AN7
	1	1	0	1	AN7
	1	1	1	0	AN7
	1	1	1	1	AN7
1	0	0	0	0	Internal_6,
	0	0	0	1	Internal_7
	0	0	1	0	Internal_0
	0	0	1	1	Internal_1
	0	1	0	0	VRH
	0	1	0	1	VRL
	0	1	1	0	(VRH+VRL) / 2
	0	1	1	1	Reserved
	1	0	0	0	Internal_2
	1	0	0	1	Internal_3
	1	0	1	0	Internal_4
	1	0	1	1	Internal_5
	1	1	Х	Х	Reserved

Table 11-15. Analog Input Channel Select Coding

Chapter 13 Analog-to-Digital Converter (ADC10B12CV2)

Revision History

Version Number	Revision Date	Effective Date	Author	Description of Changes
V02.00	13 May 2009	13 May 2009		Initial version copied from V01.06, changed unused Bits in ATDDIEN to read logic 1
V02.01	30.Nov 2009	30.Nov 2009		Updated Table 13-15 Analog Input Channel Select Coding - description of internal channels. Updated register ATDDR (left/right justified result) description in section 13.3.2.12.1/13-475 and 13.3.2.12.2/13-476 and added table Table 13-21 to improve feature description.
V02.02	09 Feb 2010	09 Feb 2010		Fixed typo in Table 13-9- conversion result for 3mV and 10bit resolution
V02.03	26 Feb 2010	26 Feb 2010		Corrected Table 13-15 Analog Input Channel Select Coding - description of internal channels.
V02.04	14 Apr 2010	14 Apr 2010		Corrected typos to be in-line with SoC level pin naming conventions for VDDA, VSSA, VRL and VRH.
V02.05	25 Aug 2010	25 Aug 2010		Removed feature of conversion during STOP and general wording clean up done in Section 13.4, "Functional Description
V02.06	09 Sep 2010	09 Sep 2010		Update of internal only information.
V02.07	11 Feb 2011	11 Feb 2011		Connectivity Information regarding internal channel_6 added to Table 13-15.
V02.08	29 Mar 2011	29 Mar 2011		Fixed typo in bit description field Table 13-14 for bits CD, CC, CB, CA. Last sentence contained a wrong highest channel number (it is not AN7 to AN0 instead it is AN11 to AN0).
V02.09	22. Jun 2012	22. Jun 2012		Update of register write access information in section 13.3.2.9/13-473.
V02.10	29 Jun 2012	29. Jun 2012		Removed IP name in block diagram Figure 13-1
V02.11	02 Oct 2012	02 Oct 2012		Added user information to avoid maybe false external trigger events when enabling the external trigger mode (Section 13.4.2.1, "External Trigger Input).

Scalable Controller Area Network (S12MSCANV3)

Module Base +	+ 0x00XF						Access: Us	er read/write ¹
	7	6	5	4	3	2	1	0
R	TSR7	TSR6	TSR5	TSR4	TSR3	TSR2	TSR1	TSR0
w								
Reset:	х	х	х	х	х	х	х	х

Figure 18-38. Time Stamp Register — Low Byte (TSRL)

¹ Read: or transmit buffers: Anytime when TXEx flag is set (see Section 18.3.2.7, "MSCAN Transmitter Flag Register (CANTFLG)") and the corresponding transmit buffer is selected in CANTBSEL (see Section 18.3.2.11, "MSCAN Transmit Buffer Selection Register (CANTBSEL)"). For receive buffers: Anytime when RXF is set. Write: Unimplemented

18.4 Functional Description

18.4.1 General

This section provides a complete functional description of the MSCAN.

PAMOD	PEDGE	Pin Action
0	0	Falling edge
0	1	Rising edge
1	0	Div. by 64 clock enabled with pin high level
1	1	Div. by 64 clock enabled with pin low level

Table 23-19. Pin Action

NOTE

If the timer is not active (TEN = 0 in TSCR), there is no divide-by-64 because the \div 64 clock is generated by the timer prescaler.

Table 23-20. Timer Clock Selection

CLK1	CLK0	Timer Clock		
0	0	Use timer prescaler clock as timer counter clock		
0	1	Use PACLK as input to timer counter clock		
1	0	Use PACLK/256 as timer counter clock frequency		
1	1	Use PACLK/65536 as timer counter clock frequency		

For the description of PACLK please refer Figure 23-30.

If the pulse accumulator is disabled (PAEN = 0), the prescaler clock from the timer is always used as an input clock to the timer counter. The change from one selected clock to the other happens immediately after these bits are written.

23.3.2.16 Pulse Accumulator Flag Register (PAFLG)

1 .



Read: Anytime

Write: Anytime

When the TFFCA bit in the TSCR register is set, any access to the PACNT register will clear all the flags in the PAFLG register. Timer module or Pulse Accumulator must stay enabled (TEN=1 or PAEN=1) while clearing these bits.

16 KByte Flash Module (S12FTMRG16K1V1)

Address & Name		7	6	5	4	3	2	1	0
0x0003	R	0	0	0	0	0	0	0	0
FRSV0	w								
0x0004 FCNFG	R W	CCIE	0	0	IGNSF	0	0	FDFD	FSFD
0x0005 FERCNFG	R W	0	0	0	0	0	0	DFDIE	SFDIE
0x0006 FSTAT	R W	CCIF	0	ACCERR	FPVIOL	MGBUSY	RSVD	MGSTAT1	MGSTAT0
0x0007 FERSTAT	R W	0	0	0	0	0	0	DFDIF	SFDIF
0x0008 FPROT	R W	FPOPEN	RNV6	FPHDIS	FPHS1	FPHS0	RNV2	RNV1	RNV0
0x0009 EEPROT	R W	DPOPEN	0	0	DPS4	DPS3	DPS2	DPS1	DPS0
0x000A FCCOBHI	R W	CCOB15	CCOB14	CCOB13	CCOB12	CCOB11	CCOB10	CCOB9	CCOB8
0x000B FCCOBLO	R W	CCOB7	CCOB6	CCOB5	CCOB4	CCOB3	CCOB2	CCOB1	CCOB0
0x000C FRSV1	R W	0	0	0	0	0	0	0	0
0x000D FRSV2	R W	0	0	0	0	0	0	0	0
0x000E FRSV3	R W	0	0	0	0	0	0	0	0
0x000F FRSV4	R W	0	0	0	0	0	0	0	0
0x0010 FOPT	R W	NV7	NV6	NV5	NV4	NV3	NV2	NV1	NV0

Figure 24-4. FTMRG16K1 Register Summary (continued)

16 KByte Flash Module (S12FTMRG16K1V1)



Figure 24-25. Generic Flash Command Write Sequence Flowchart

64 KByte Flash Module (S12FTMRG64K1V1)

CCOBIX[2:0]	Byte	FCCOB Parameter Fields (NVM Command Mode)
010	HI	Data 0 [15:8]
010	LO	Data 0 [7:0]
011	HI	Data 1 [15:8]
011	LO	Data 1 [7:0]
100	HI	Data 2 [15:8]
100	LO	Data 2 [7:0]
101	HI	Data 3 [15:8]
	LO	Data 3 [7:0]

Table 27-24. FCCOB - NVM Command Mode (Typical Usage)

27.3.2.12 Flash Reserved1 Register (FRSV1)

This Flash register is reserved for factory testing.

Offset Module Base + 0x000C

Offset Module Base + 0x000D



Figure 27-18. Flash Reserved1 Register (FRSV1)

All bits in the FRSV1 register read 0 and are not writable.

27.3.2.13 Flash Reserved2 Register (FRSV2)

This Flash register is reserved for factory testing.



Figure 27-19. Flash Reserved2 Register (FRSV2)

All bits in the FRSV2 register read 0 and are not writable.

27.3.2.14 Flash Reserved3 Register (FRSV3)

This Flash register is reserved for factory testing.

Chapter 28 96 KByte Flash Module (S12FTMRG96K1V1)

Revision Number	Revision Date	Sections Affected	Description of Changes
V01.04	17 Jun 2010	28.4.6.1/28-100 2 28.4.6.2/28-100 3 28.4.6.3/28-100 4 28.4.6.14/28-10 13	Clarify Erase Verify Commands Descriptions related to the bits MGSTAT[1:0] of the register FSTAT.
V01.05	20 aug 2010	28.4.6.2/28-100 3 28.4.6.12/28-10 10 28.4.6.13/28-10 12	Updated description of the commands RD1BLK, MLOADU and MLOADF
Rev.1.27	31 Jan 2011	28.3.2.9/28-985	Updated description of protection on Section 28.3.2.9

Table 28-1. Revision History

28.1 Introduction

The FTMRG96K1 module implements the following:

- 96Kbytes of P-Flash (Program Flash) memory
- 3 Kbytes of EEPROM memory

The Flash memory is ideal for single-supply applications allowing for field reprogramming without requiring external high voltage sources for program or erase operations. The Flash module includes a memory controller that executes commands to modify Flash memory contents. The user interface to the memory controller consists of the indexed Flash Common Command Object (FCCOB) register which is written to with the command, global address, data, and any required command parameters. The memory controller must complete the execution of a command before the FCCOB register can be written to with a new command.

CAUTION

A Flash word or phrase must be in the erased state before being programmed. Cumulative programming of bits within a Flash word or phrase is not allowed.



Figure 28-1. FTMRG96K1 Block Diagram

28.2 External Signal Description

The Flash module contains no signals that connect off-chip.

CCOBIX[2:0]	FCCOB Parameters				
000	0x12	Global address [17:16] to identify EEPROM block			
001	Global address [15:0] anywhere within the sector to be erased. See Section 31.1.2.2 for EEPROM sector size.				

 Table 31-64. Erase EEPROM Sector Command FCCOB Requirements

Upon clearing CCIF to launch the Erase EEPROM Sector command, the Memory Controller will erase the selected Flash sector and verify that it is erased. The CCIF flag will set after the Erase EEPROM Sector operation has completed.

Register	Error Bit	Error Condition				
		Set if CCOBIX[2:0] != 001 at command launch				
		Set if command not available in current mode (see Table 31-27)				
	ACCENT	Set if an invalid global address [17:0] is suppliedsee Table 31-3)				
FSTAT		Set if a misaligned word address is supplied (global address [0] != 0)				
	FPVIOL	Set if the selected area of the EEPROM memory is protected				
	MGSTAT1	Set if any errors have been encountered during the verify operation				
	MGSTAT0	Set if any non-correctable errors have been encountered during the verify operation				

Table 31-65. Erase EEPROM Sector Command Error Handling

31.4.7 Interrupts

The Flash module can generate an interrupt when a Flash command operation has completed or when a Flash command operation has detected an ECC fault.

Table 31-66.	Flash	Interrupt	Sources
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Interrupt Source	Interrupt Flag	Local Enable	Global (CCR) Mask
Flash Command Complete	CCIF (FSTAT register)	CCIE (FCNFG register)	l Bit
ECC Double Bit Fault on Flash Read	DFDIF (FERSTAT register)	DFDIE (FERCNFG register)	l Bit
ECC Single Bit Fault on Flash Read	SFDIF (FERSTAT register)	SFDIE (FERCNFG register)	l Bit

D.5 32 LQFP Mechanical Dimensions



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TITLE: LOW PROFILE QUAD FLAT PACK (LQFP) 32 LEAD, 0.8 PITCH (7 X 7 X 1.4)		DOCUMENT NO: 98ASH70029A		RE∨: D
		CASE NUMBER: 873A-03		19 MAY 2005
		STANDARD: JE	DEC MS-026 BBA	